

# **■**WEETECH

The W 454 combines HIGH-END test parameters with an attractive cost/performance ratio. Cable assemblies and components in the aerospace, medical and transportation industries can be tested with remarkable voltages up to 2,250 Vdc/1,500 Vac and currents up to 3 A. Distribution of the test points in small, weight optimized matrix cases, random connection of the adapter cables equipped with ID chips at any output connector and modules for the functional test are available as an option.

# Generators and Measuring Units

| Continuity, Short and  | LV-GEN   |   |
|------------------------|--|---|
| Component Test         | · Current  | 0,5 mA up to 3 A  |
|                        | · Current ranges   | 10 mA, 100 mA, 1 A, 3 A   |
|                        | · Voltage  | 0 to 40 V   |
|                        | · Output rating  | 120 W   |
|                        | Connection/Resistor  | 1 Ohm up to 10 MOhms  |
|                        |  | 3 mOhms to 100 Ohms (Four Terminal Measurement)                               |
|                        |  | Consideration of the power limits of resistive components                     |
|                        | · Capacitance  | 20 nF to 10,000 μF  |
|                        | Components   | Diodes, Zener diodes, LEDs, Varistors   |
|                        | · LV isolation   | Typically up to 100 MOhms   |
|                        | · Voltage measurement  | 0 to ± 500 V, frequency DC to 1 kHz   |
| Insulation, Hi-Pot, DC | HVG 2-5000 (optional)  |   |
| and AC ARC Test        | · DC Voltage   | 40 to 2,250 Vdc   |
|                        | · AC Voltage   | 40 to 1,500 Vac   |
|                        | · Current  | 0 to 100 mA, 0 to 70 mA <sub>eff</sub> for voltages up to 1,500 Vdc/1,060 Vac |
|                        |  | 0 to 50 mA, 0 to 35 mA <sub>eff</sub> for voltages up to 2,250 Vdc/1,500 Vac  |
|                        | · Ramps  | 500 V/s, 100 V/ms, 1,000 V/ms, programmable from 1,000 V/ms to 1 V/s          |
|                        | · Measurement  | Typically up to 10 GOhms, up to 500 MOhms ±1 %                                |
|                        | · Highly sensitive ARC detection with step detector (voltage drop), slew detector (slew rate) and programmable dldt detector |   |
| Insulation, Hi-Pot     | HV-DC  |   |
| and DC ARC Test        | · DC Voltage   | 40 to 2,250 Vdc   |
|                        | · Current  | Touch safe generator, up to 1 mA  |
|                        | · Ramps  | 500 V/s, 20 V/ms, 200 V/ms, 2,000 V/ms  |
|                        | · Measurement  | Typically up to 10 GOhms, up to 500 MOhms ±1 %                                |
|                        | · ARC detection with unique  | voltage and slew rate recognition   |
| Hi-Pot and AC ARC Test | HV-AC (optional)   |   |
|                        | AC Voltage   | 40 to 1,500 Vac   |
|                        | · Real current   | Touch safe generator, up to 0.5 mA <sub>eff</sub>                             |
|                        | · Imaginary current  | Touch safe generator, up to 3.5 mA <sub>eff</sub>                             |
|                        | · Ramps  | 500 V/s, 20 V/ms, 2,000 V/ms  |
|                        | · ARC detection with unique voltage and slew rate recognition  |   |
| Attenuation and        | GEN 1 MHz (optional)   |   |
| Polarity Test          | · Frequency  | 10 to 1,000 kHz   |
|                        | · Waveform   | Sine  |
|                        | · Attenuation measurement  | 0 to 40 dB  |
|                        | · Accuracy   | in the range of 10 to 1,000 kHz   |
|                        | · Transmission level   | 500 mVp at 50 0hms/77 0hms  |
|                        |  | 3.97 dBm at 50 Ohms   |
|                        |  | 2.10 dBm at 77 Ohms   |
|                        |  |   |

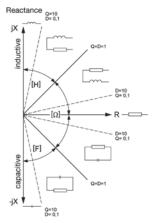
# Generators and Measuring Units

# Component, Twisted-Pair and Shield Test

#### RLC Meter (optional)

Frequency DC to 100 kHz
Capacitance 10 pF to 10,000 μF
Inductance 1 μH to 1 H

- · Checks pair inversion and shield integrity
- · Fast impedance measurement with typically 70 ms
- · RLC Measurement Functions



- Ω Ohmic range
- H Inductive range
- F Capacitive ran
- IZI Impedance
- Θ Phase angle
- R Resistance (serial or parallel)
- C Capacitance (serial or parallel
- L Inductance (serial or parallel)
- D Dissipation factor
- Q Quality factor

Typical values, valid at the front panel of the tester without adaptation at 25° C and a relative humidity less than 60 %

# **■** Functional Test

- · Supply of the UUT with programmable voltages up to 125 Vdc/250 Vac
- $\cdot$  Emulation of the switching processes
- · Reproduction of the functional environment, e.g. by electronic loads, frequencies etc.
- $\cdot$  Functional test of push buttons and switches
- · Measurement of time dependent current/voltage wave forms
- · Import of characteristic curves of external devices and display
- · Integrated, programmable voltage/current source with up to 40 Vdc/3 A (GEN 40-3) or LAN/IEEE 488/GPIB controlled power supplies with higher performance

# Switching Matrix

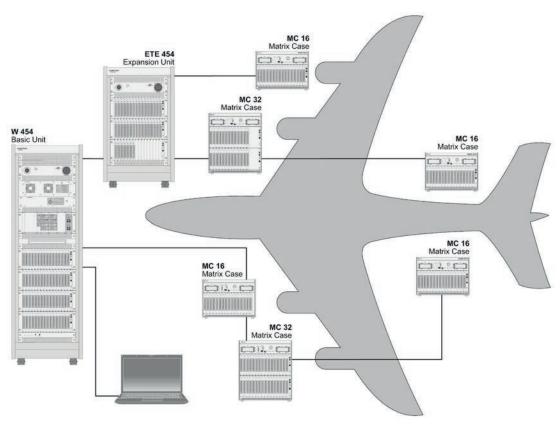
### Modules for Wiring Test

- · Versions for voltages up to 2,250 Vdc/1,500 Vac
- · Various output connectors available

#### Modules for Functional Test

- · Combi modules, equipped with test point cards for voltages up to 125 Vdc/250 Vac, current up to 3 A
- $\cdot$  Measurement cards according to the application
- $\cdot$  Power modules for voltages up to 60 Vdc/25 Vac, current up to 3 A
- · Separate high-current module for current up to 25 A, voltages up to 25 Vdc/250 Vac

# Distributed Matrix



Distributed matrix W 454 with different matrix cases and customized expansion units

## **■** Further Details

#### Interfaces

- · Ethernet interface
- $\cdot$  Remote Control interface to trigger external devices, e.g. feeders and fixtures
- $\cdot$  Software controlled integration of external devices via LAN, IEEE 488/GPIB, RS 232, PC-Bus, CAN-Bus, CANOPEN-Bus, K-Line
- $\cdot \ \text{Integration into customer specific ERP-Systems}$

#### Dimensions

- · W 454, ETE 454: 19 inch rack system, height customized
- · MMC 16 with max. 1,024 test points, W x D x H (mm): 450 x 560 x 315
- MC 32 with max. 2,048 test points, W x D x H (mm): 450 x 560 x 495
- · MC 16, MC 32: Weight optimized, portable 19 inch enclosure with retractable handles, stackable

#### Power Supply

- · W 454, ETE 454 3-phase: 200 to 400 Vac, 50 to 60 Hz, max. 4,000 VA
- · W 454, ETE 454 1-phase: 100 to 230 Vac, 50 to 60 Hz, max. 1,600 VA

